

University of Stuttgart

Faculty of Computer Science, Electrical Engineering and Information Technology

Program:

- 13:00 Opening Miriam Mehl, Deputy Dean of the Faculty of Computer Science, Electrical Engineering and Information Technology
- 13:10 Welcome Addresses Wolfram Ressel, Rector of the University of Stuttgart Hans-Juergen Wagner, CEO Advantest Europe GmbH
- 13:40 The Graduate School "Intelligent Methods for Semiconductor Test and Reliability" Hans-Joachim Wunderlich, Professor, University of Stuttgart
- 14:10 Research Problems for the Graduate School Jochen Rivoir, Fellow, Advantest Europe GmbH
- 14:40 Intelligent Methods for Semiconductor Test and Reliability Krishnendu Chakrabarty, Duke University, NC
- 15:30 Reception

Please register until January 22nd, 2019.

Intelligent Methods for Semiconductor Test and Reliability

Kick-off Colloquium of the Graduate School

7th February 2019 Room 38.04 Universitätsstraße 38





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Today's economy and entire society rest upon the dependability of information technology and especially the underlying hardware infrastructure. Thoroughly tested systems are mandatory for a responsible use of technology. Without test and diagnosis, there would be no economical way to develop new technology nodes and to bring novel, complex products into the market. Summarizing, test and diagnosis form an enabling technology for the information society.

Semiconductor test is becoming more and more challenging, since recent technology allows the implementation of systems of tremendous complexity in many aspects. New challenges are only mastered by combining many fields from computer science and electrical engineering including machine learning or artificial intelligence in a structured way. To face these challenges, these challenges, the University of Stuttgart will establish a Graduate School "Intelligent Methods for Semiconductor Test and Reliability" which will be funded by the company Advantest, Tokyo, and which will closely cooperate with the branch in Böblingen. Around 10 PhD candidates and one Juniorprofessor will work together towards new solutions.

You may register online via: www.iti.uni-stuttgart.de/gradreg

Contact for more information: Mirjam Breitling, Institute of Computer Architecture Phone +49 711 685 88362 Email: sekretariat@iii.uni-stuttgart.de

Directions: https://www.f05.unistultgart.de/en/faculty/contact/index.html Intelligent Methods for Semiconductor Test and Reliability

